GSR40P15T

Group-Semi P-Channel MOSFET

GENERAL DESCRIPTION

GroupSemiconductor(GS) has series Trench power MOSFET platforms for voltage up 20V to 200 volts, both with design service and manufacturing capability, including cell, termination design and simulation.

The GS 40V 15A P-Channel Power MOSFET is a Low voltage P channel Trench power MOSFET sample with advanced technology to have better characteristics, such as fast switching time, low Ciss and Crss, low on resistance and excellent avalanche characteristics, making it especially suitable for applications which require superior power density and outstanding efficiency.

GENERAL FEATURES

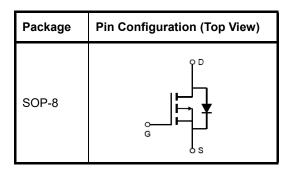
- VDS =-40V,ID =-15A
- RDS(ON) <45mΩ @ VGS=-10V ● High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high EAS
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

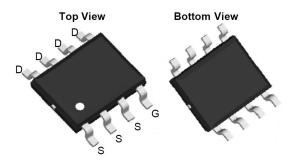
Application

- BLDC
- Charger

Electrical Characteristics

| Parameter | Conditions | Min | Тур | Max | Unit |
|---|--|---|---|--|--|
| stics | | | | t | |
| Drain-Source Breakdown Voltage | VGS = 0V, ID = -250μA, TJ = 25℃ | -40 | - | - | v |
| Gate-Source Voltage | | ±25 | | | V |
| Continuous DrainCurrent | TC=25°C TC=100°C | -15 -10 | | | Α |
| Pulsed Drain Current ^c | | -60 | | | Α |
| Avalanche Current ^c | | 25 | | | Α |
| Avalanche energy L=0.1mH ^c | | 30 | | | mJ |
| Power Dissipation ^B | TC=25°C TC=100°C | 83 33 | | | w |
| Power Dissipation ^A | TC=25°C TC=70°C | 7.3 4.7 | | | w |
| Junction and Storage Temperature Range | | -55 to 150 | | | °C |
| Zero Gate Voltage Drain Current | VDS = -30V, VGS = 0V -TJ = 55℃ | - | - | -1 -5 | μA μA |
| Gate-Body Leakage Current, Forward | VGS = 12V, VDS = 0V | - | - | 100 | nA |
| Gate-Body Leakage Current, Reverse | VGS = -12V, VDS = 0V | - | - | -100 | nA |
| | stics Drain-Source Breakdown Voltage Gate-Source Voltage Continuous DrainCurrent Pulsed Drain Current ^C Avalanche Current ^C Avalanche energy L=0.1mH ^C Power Dissipation ^B Power Dissipation ^A Junction and Storage Temperature Range Zero Gate Voltage Drain Current Gate-Body Leakage Current, Forward Gate-Body Leakage Current, | stics Drain-Source Breakdown Voltage VGS = 0V, ID = -250μA, TJ = 25°C Gate-Source Voltage TC=25°C TC=100°C Pulsed Drain Current ^C Avalanche Current ^C Avalanche energy L=0.1mH ^C Power Dissipation ^B Power Dissipation ^A TC=25°C TC=100°C Power Dissipation ^A TC=25°C TC=70°C Junction and Storage Temperature Range TC=25°C TC=70°C Zero Gate Voltage Drain Current VDS = -30V, VGS = 0V -TJ = 55°C Gate-Body Leakage Current, Forward VGS = 12V, VDS = 0V Gate-Body Leakage Current, VGS = -12V, VDS = 0V | SticsDrain-Source Breakdown VoltageVGS = 0V, ID = -250µA, TJ = 25°C-40Gate-Source Voltage ± 25 Continuous DrainCurrentTC=25°C TC=100°C-15 -10Pulsed Drain Current °-60Avalanche Current °25Avalanche energy L=0.1mH °30Power Dissipation BTC=25°C TC=100°C83 33Power Dissipation ATC=25°C TC=70°C7.3 4.7Junction and Storage Temperature Range-55 toZero Gate Voltage Drain CurrentVDS = -30V, VGS = 0V -TJ = 55°C-Gate-Body Leakage Current, ForwardVGS = 12V, VDS = 0V Gate-Body Leakage Current, ForwardVGS = -12V, VDS = 0V | sticsDrain-Source Breakdown VoltageVGS = 0V, ID = -250µA, TJ = 25°C-40-Gate-Source Voltage ± 25 -Continuous DrainCurrentTC=25°C TC=100°C-15 -10Pulsed Drain Current ° Avalanche Current °-60Avalanche Current ° Power Dissipation B25Power Dissipation ATC=25°C TC=100°C83 33Power Dissipation ATC=25°C TC=70°C7.3 4.7Junction and Storage Temperature Range-55 to 150Zero Gate Voltage Drain CurrentVDS = -30V, VGS = 0V -TJ = 55°C-Gate-Body Leakage Current, ForwardVGS = 12V, VDS = 0V VGS = -12V, VDS = 0V | sticsDrain-Source Breakdown VoltageVGS = 0V, ID = -250µA, TJ = 25°C-40Gate-Source Voltage±25Continuous DrainCurrentTC=25°C TC=100°C-15 -10-Pulsed Drain Current °-60-Avalanche Current °-60-Avalanche energy L=0.1mH °30-Power Dissipation BTC=25°C TC=100°C83 33-Power Dissipation ATC=25°C TC=70°C7.3 4.7-Junction and Storage Temperature Range-55 to 150-Zero Gate Voltage Drain CurrentVDS = -30V, VGS = 0V -TJ = 55°CGate-Body Leakage Current, ForwardVGS = 12V, VDS = 0V VGS = -12V, VDS = 0VGate-Body Leakage Current, ForwardVGS = -12V, VDS = 0V 100 |







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| | Maximum Junction-to-Ambient * | | 14 | | | °C/W |
|----------------|--|---|------|------|------|------|
| Roja | Maximum Junction-to-Ambient ** | | 40 | | | °C/W |
| Rejc | Maximum Junction-to-Case | | 1.1 | | | °C/W |
| On Characteris | stics | | | I | | |
| VGS(th) | Gate Threshold Voltage | VDS = VGS, ID = 250µA | -1.0 | | -3.0 | V |
| RDS(on) | Static Drain-Source On- Resistance | VGS = -10V, ID = -10A | - | 35 | 45 | mΩ |
| gFS | Forward Transconductance | VDS = -5V, ID = -10A | - | 3 | - | S |
| Rg | Gate resistance | VGS=0V, VDS=0V, f=1MHz | - | 3.2 | - | Ω |
| Dynamic Char | acteristics | | | | | |
| Ciss | Input Capacitance | VDS = -15V, VGS = 0V, f=1MHz | - | 1550 | - | pF |
| Coss | Output Capacitance | | - | 120 | - | pF |
| Crss | Reverse Transfer Capacitance | | - | 80 | - | pF |
| Switching Cha | racteristics | | | · | · | |
| td(on) | Turn-On Delay Time | VDS = -20V, RG = 3Ω, ID = -12A , VGS = -10V (Note 5, 6) | - | 11 | - | ns |
| tr | Turn-On Rise Time | | - | 9.4 | - | ns |
| td(off) | Turn-Off Delay Time | | - | 24 | - | ns |
| tf | Turn-Off Fall Time | | - | 12 | - | ns |
| Qg(-10V) | Total Gate Charge | VDS = -20V, ID = -12A, VGS =10V (Note 5, 6) | - | 28 | - | nC |
| Qg-(4.5V) | Total Gate Charge | | - | 24 | - | nC |
| Qgs | Gate-Source Charge | | - | 4.6 | - | nC |
| Qgd | Gate-Drain Charge | | - | 10 | - | nC |
| Drain-Source I | Diode Characteristics and Maximum | Ratings | | | | |
| IS | Maximum Continuous Drain-So Current | Maximum Continuous Drain-Source Diode Forward Current | | - | - | Α |
| ISM | Maximum Pulsed Drain-Source | Maximum Pulsed Drain-Source Diode Forward Current | | - | -25 | Α |
| VSD | Drain-Source Diode Forward Voltage | VGS = 0V, IS = -1A | - | -0.7 | -1.2 | v |
| trr | Reverse Recovery Time | VGS = 0V, IS =-6A dIF/dt =-100A/µs (Note 5) | - | 24 | - | ns |
| Qrr | Reverse Recovery Charge | | - | 30 | - | nC |

A: The value of R_{0JA} is measured with the device mounted on 1 in $_2$ FR-4 board with 2oz. Copper, in a still air environment with T $_A$ = 25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t \leq 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\text{BJA}}$ is the sum of the thermal impedence from junction to lead R_{\text{BJL}} and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using < $300\mu s$ pulses, duty cycle 0.5% max.

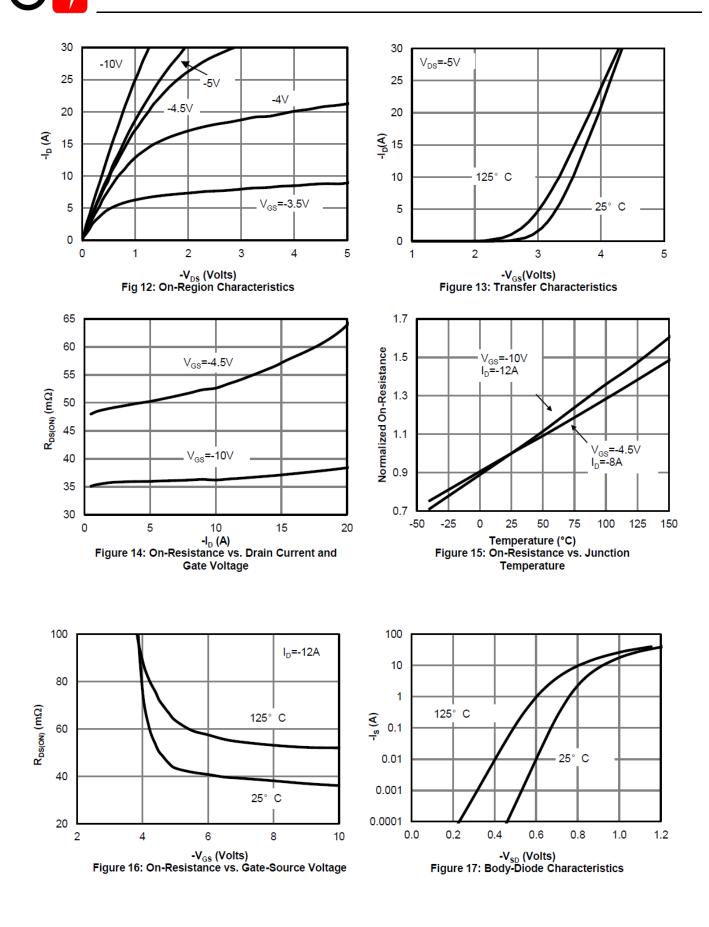
E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T A=25°C. The

SOA curve provides a single pulse rating.

F. The current rating is based on the t \leqslant 10s thermal resistance rating.

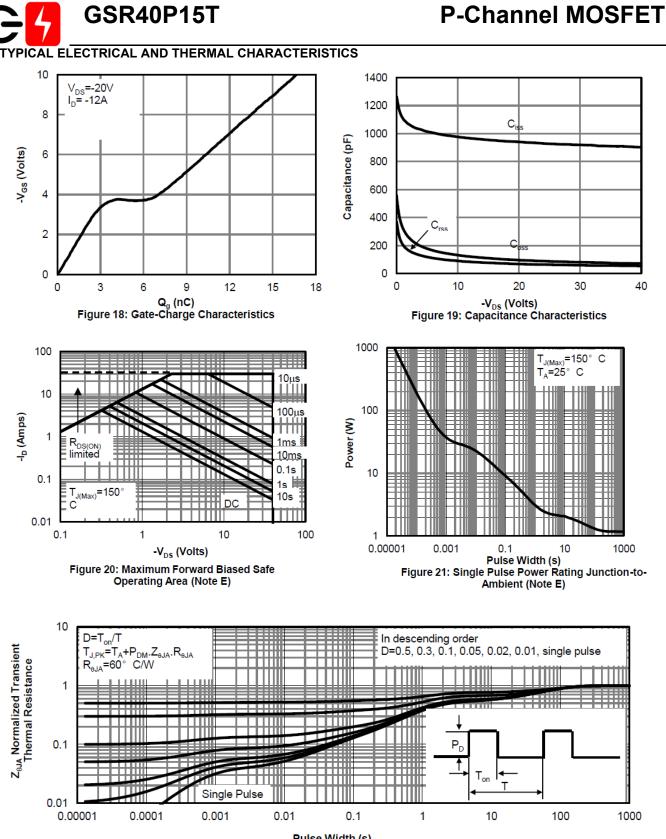
G. EAR and IAR ratings are based on low frequency and duty cycles to keep Tj=25C.

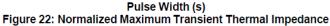
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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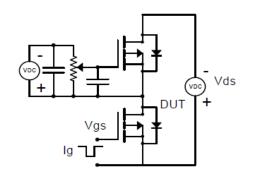
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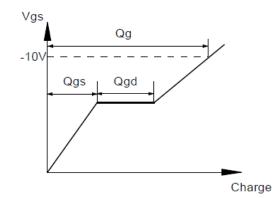




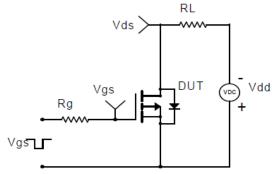


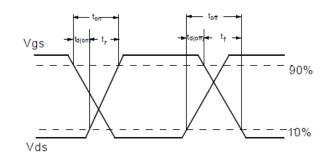
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

